

IGBT3 Chip

Features:

- 1700V Trench + Field Stop technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

• power module



Applications:

drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	
SIGC42T170R3GE	1700V	29A	6.5 x 6.46 mm ²	sawn on foil	

MECHANICAL PARAMETER

Raster size	6.5 x 6.46				
Emitter pad size (incl. gate pad)	4.27 x 4.27	mm ²			
Gate pad size	1.18 x 1.09] """			
Area total / active	42 / 28.7				
Thickness	190				
Wafer size	200	mm			
Max.possible chips per wafer	641 pcs				
Passivation frontside	Photoimide				
Pad metal	3200 nm AlSiCu				
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	Electrically conductive glue or solder				
Wire bond	Al, <500μm				
Reject ink dot size Ø 0.65mm; max 1.2mm					
Recommended storage environment	Store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage, T _j =25 °C	V _{CE}	1700	V	
DC collector current, limited by T _{j max}	I _C	1)	А	
Pulsed collector current, t _p limited by T _{j max}	I _{c,puls}	87	А	
Gate emitter voltage	V _{GE}	±20	V	
Maximum junction and storage temperature	$T_{\rm vj,max}$, $T_{\rm stg}$	-55 + 150	°C	
Short circuit data $^{2)}$ V _{GE} = 15V, V _{CC} = 1200V, T _{vj} = 125°C	$t_{p, max}$	10	μs	
Reverse bias safe operating area ²⁾ (RBSOA)	$I_{C,max} = 58A, V_{CE,max} = 1700V, T_{vj,op} \le 125^{\circ}C$			

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on wafer), $T_{\rm j}$ =25 °C

Parameter	Symbol	Conditions	Value			Unit
Turumeter	- Cymbol	Conditions	min.	typ.	max.	
Collector-Emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I_{C} = 1.5mA	1700			
Collector-Emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =29A	1.6	2	2.4	V
Gate-Emitter threshold voltage	V _{GE(th)}	I _C =1.2mA , V _{GE} =V _{CE}	5.2	5.8	6.4	
Zero gate voltage collector current	I _{CES}	V _{CE} =1700V , V _{GE} =0V			2	μA
Gate-Emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			600	nA
Integrated gate resistor	R _{Gint}			32		Ω

ELECTRICAL CHARACTERISTICS (not subject to production test - verified by design / characterization)

Parameter	Symbol	Conditions	Value			Unit
	Oymboi	Conditions	min.	typ.	max.	Oiiit
Input capacitance	Ciss	$V_{CE}=25V$,		2500		
Output capacitance	Coss	$V_{GE}=0V$,		105		pF
Reverse transfer capacitance	Crss	f=1MHz		84		<u> </u>

²⁾ not subject to production test - verified by design/characterization



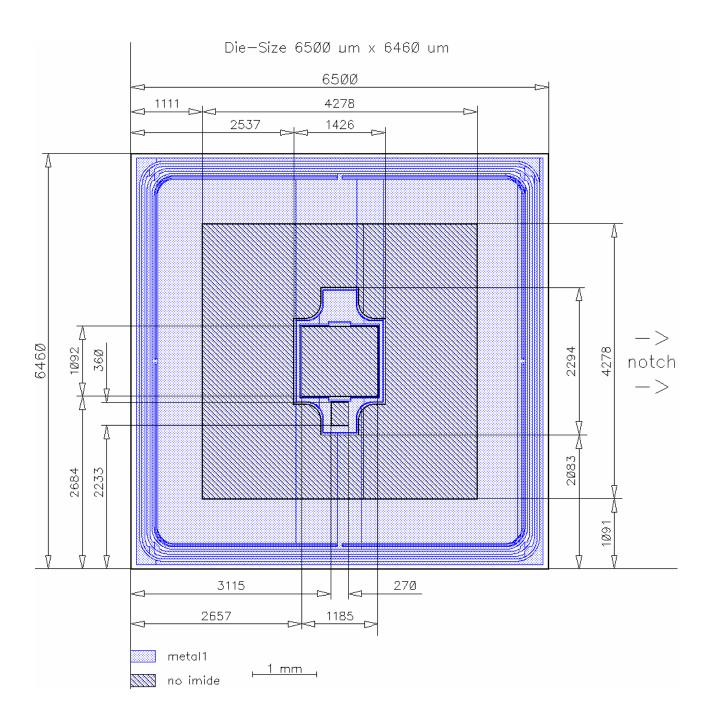
SWITCHING CHARACTERISTICS inductive load (not subject to production test - verified by design / characterization)

Parameter	Symbol	Conditions 1)	Value			Unit
- arameter	Symbol	Conditions	min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	$T_{j}{=}125^{\circ}\text{C}$ $V_{CC}{=}900\text{V},$ $I_{C}{=}29\text{A},$ $V_{GE}{=}{-}15/15\text{V},$ $R_{G}{=}18\Omega$		400		
Rise time	t_{r}			50		lie
Turn-off delay time	$t_{d(off)}$			800		μs
Fall time	t_{f}			300		

 $^{^{1)}}$ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING





FURTHER ELECTRICAL CHARACTERISTICS				
This chip data sheet refers to the device data sheet				
DESCRIPTION				
AQL 0,65 for visual inspection according to failu	ure catalogue			
Electrostatic Discharge Sensitive Device according to MIL-STD 883				
Test-Normen Villach/Prüffeld				

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